

DATA SHEET

74ALVT16541

2.5V/3.3V 16-bit buffer/driver (3-State)

Product specification

Supersedes data of 1996 Aug 13

IC23 Data Handbook

1998 Feb 13

2.5V/3.3V 16-bit buffer/driver (3-State)

74ALVT16541

FEATURES

- 16-bit universal bus interface
- 5V I/O compatible
- 3-State buffers
- Output capability: +64mA/-32mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Power-up 3-State
- No bus current loading when output is tied to 5V bus
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model

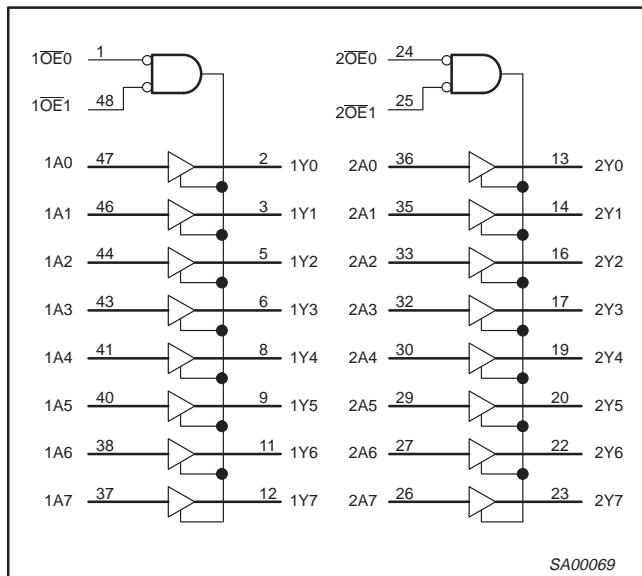
QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS $T_{amb} = 25^\circ C$	TYPICAL		UNIT
			2.5V	3.3V	
t_{PLH} t_{PHL}	Propagation delay n_{Ax} to n_{Yx}	$C_L = 50\text{pF}$	1.8 1.7	1.4 1.4	ns
C_{IN}	Input capacitance $n_{\bar{OE}x}$	$V_I = 0V$ or V_{CC}	3	3	pF
C_{Out}	Output pin capacitance	Outputs disabled; $V_O = 0V$ or V_{CC}	9	9	pF
I_{CCZ}	Total supply current	Outputs disabled	40	70	μA

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
48-Pin Plastic SSOP Type III	-40°C to +85°C	74ALVT16541 DL	AV16541 DL	SOT370-1
48-Pin Plastic TSSOP Type II	-40°C to +85°C	74ALVT16541 DGG	AV16541 DGG	SOT362-1

LOGIC SYMBOL



DESCRIPTION

The 74ALVT16541 is a high-performance BiCMOS product designed for V_{CC} operation at 2.5V or 3.3V with I/O compatibility up to 5V.

This device can be used as two octal buffers or one 16-bit buffer. The device is ideal for driving bus lines.

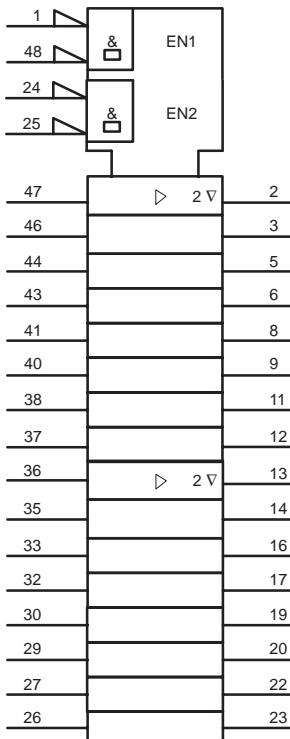
PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
47, 46, 44, 43, 41, 40, 38, 37, 36, 35, 33, 32, 30, 29, 27, 26	1A0–1A7 2A0–2A7	Data inputs
2, 3, 5, 6, 8, 9, 11, 12, 13, 14, 16, 17, 19, 20, 22, 23	1Y0–1Y7 2Y0–2Y7	Data outputs
1, 48 24, 25	1OE0, 1OE1, 2OE0, 2OE1	Output enables
4, 10, 15, 21, 28, 34, 39, 45	GND	Ground (0V)
7, 18, 31, 42	V_{CC}	Positive supply voltage

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LOGIC SYMBOL (IEEE/IEC)



PIN CONFIGURATION

1 $\bar{OE}0$	1	48	1 $\bar{OE}1$
1Y0	2	47	1A0
1Y1	3	46	1A1
GND	4	45	GND
1Y2	5	44	1A2
1Y3	6	43	1A3
V _{CC}	7	42	V _{CC}
1Y4	8	41	1A4
1Y5	9	40	1A5
GND	10	39	GND
1Y6	11	38	1A6
1Y7	12	37	1A7
2Y0	13	36	2A0
2Y1	14	35	2A1
GND	15	34	GND
2Y2	16	33	2A2
2Y3	17	32	2A3
V _{CC}	18	31	V _{CC}
2Y4	19	30	2A4
2Y5	20	29	2A5
GND	21	28	GND
2Y6	22	27	2A6
2Y7	23	26	2A7
2 $\bar{OE}0$	24	25	2 $\bar{OE}1$

SW00150

FUNCTION TABLE

INPUTS		OUTPUTS	
n $\bar{OE}0$	n $\bar{OE}1$	nA _x	nY _x
L	L	L	L
L	L	H	H
X	H	X	Z
H	X	X	Z

H = High voltage level

L = Low voltage level

X = Don't care

Z = High Impedance "off" state

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ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		−0.5 to +4.6	V
I _{IK}	DC input diode current	V _I < 0	−50	mA
V _I	DC input voltage ³		−0.5 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	−50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	−0.5 to +7.0	V
I _{OUT}	DC output current	Output in Low state	128	mA
		Output in High state	−64	
T _{stg}	Storage temperature range		−65 to +150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
2. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.
3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	2.5V RANGE LIMITS		3.3V RANGE LIMITS		UNIT
		MIN	MAX	MIN	MAX	
V _{CC}	DC supply voltage	2.3	2.7	3.0	3.6	V
V _I	Input voltage	0	5.5	0	5.5	V
V _{IH}	High-level input voltage	1.7		2.0		V
V _{IL}	Input voltage		0.7		0.8	V
I _{OH}	High-level output current		−8		−32	mA
I _{OL}	Low-level output current		8		32	mA
	Low-level output current; current duty cycle $\leq 50\%$; f $\geq 1\text{kHz}$		24		64	
Δt/Δv	Input transition rise or fall rate; Outputs enabled		10		10	ns/V
T _{amb}	Operating free-air temperature range	−40	+85	−40	+85	°C

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DC ELECTRICAL CHARACTERISTICS (3.3V \pm 0.3V RANGE)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT	
			Temp = -40°C to +85°C				
			MIN	TYP ¹	MAX		
V_{IK}	Input clamp voltage	$V_{CC} = 3.0V$; $I_{IK} = -18mA$		-0.85	-1.2	V	
V_{OH}	High-level output voltage	$V_{CC} = 3.0$ to $3.6V$; $I_{OH} = -100\mu A$	$V_{CC} - 0.2$	V_{CC}		V	
		$V_{CC} = 3.0V$; $I_{OH} = -32mA$	2.0	2.3			
V_{OL}	Low-level output voltage	$V_{CC} = 3.0V$; $I_{OL} = 100\mu A$		0.07	0.2	V	
		$V_{CC} = 3.0V$; $I_{OL} = 16mA$		0.25	0.4		
		$V_{CC} = 3.0V$; $I_{OL} = 32mA$		0.3	0.5		
		$V_{CC} = 3.0V$; $I_{OL} = 64mA$		0.4	0.55		
I_I	Input leakage current	$V_{CC} = 3.6V$; $V_I = V_{CC}$ or GND	Control pins	0.1	± 1	μA	
		$V_{CC} = 0$ or $3.6V$; $V_I = 5.5V$		0.1	10		
		$V_{CC} = 3.6V$; $V_I = V_{CC}$	Data pins ⁴	0.5	1		
		$V_{CC} = 3.6V$; $V_I = 0V$		0.1	-5		
I_{OFF}	Off current	$V_{CC} = 0V$; V_I or $V_O = 0$ to $4.5V$		0.1	± 100	μA	
I_{HOLD}	Bus Hold current Data inputs ⁶	$V_{CC} = 3V$; $V_I = 0.8V$	75	130		μA	
		$V_{CC} = 3V$; $V_I = 2.0V$	-75	-140			
		$V_{CC} = 0V$ to $3.6V$; $V_{CC} = 3.6V$	± 500				
I_{EX}	Current into an output in the High state when $V_O > V_{CC}$	$V_O = 5.5V$; $V_{CC} = 3.0V$		50	125	μA	
$I_{PU/PD}$	Power up/down 3-State output current ³	$V_{CC} \leq 1.2V$; $V_O = 0.5V$ to V_{CC} ; $V_I = GND$ or V_{CC} ; OE/OE = Don't care		40	± 100	μA	
I_{OZH}	3-State output High current	$V_{CC} = 3.6V$; $V_O = 3.0V$; $V_I = V_{IL}$ or V_{IH}		0.5	5	μA	
I_{OZL}	3-State output Low current	$V_{CC} = 3.6V$; $V_O = 0.5V$; $V_I = V_{IL}$ or V_{IH}		0.5	-5	μA	
I_{CCH}	Quiescent supply current	$V_{CC} = 3.6V$; Outputs High, $V_I = GND$ or V_{CC} , $I_O = 0$		0.07	0.1	mA	
I_{CCL}		$V_{CC} = 3.6V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_O = 0$		3.2	5		
I_{CCZ}		$V_{CC} = 3.6V$; Outputs Disabled; $V_I = GND$ or V_{CC} , $I_O = 0$ ⁵		0.07	0.1		
ΔI_{CC}	Additional supply current per input pin ²	$V_{CC} = 3V$ to $3.6V$; One input at $V_{CC} - 0.6V$, Other inputs at V_{CC} or GND		0.04	0.4	mA	

NOTES:

- All typical values are at $V_{CC} = 3.3V$ and $T_{amb} = 25^\circ C$.
- This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
- This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From $V_{CC} = 1.2V$ to $V_{CC} = 3.3V \pm 0.3V$ a transition time of 100 μ sec is permitted. This parameter is valid for $T_{amb} = 25^\circ C$ only.
- Unused pins at V_{CC} or GND.
- I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
- This is the bus hold overdrive current required to force the input to the opposite logic state.

AC CHARACTERISTICS (3.3V \pm 0.3V RANGE) $GND = 0V$; $t_R = t_F = 2.5ns$; $C_L = 50pF$; $R_L = 500\Omega$; $T_{amb} = -40^\circ C$ to $+85^\circ C$.

SYMBOL	PARAMETER	WAVEFORM	LIMITS			UNIT	
			$V_{CC} = 3.3V \pm 0.3V$				
			MIN	TYP ¹	MAX		
t_{PLH} t_{PHL}	Propagation delay nAx to nYx	1	0.5 0.5	1.4 1.4	2.3 2.3	ns	
t_{PZH} t_{PZL}	Output enable time to High and Low level	2	1.0 1.0	3.0 2.3	4.8 3.7	ns	
t_{PHZ} t_{PLZ}	Output disable time from High and Low Level	2	1.5 1.5	3.3 2.8	4.7 3.9	ns	

NOTE:

- All typical values are at $V_{CC} = 3.3V$ and $T_{amb} = 25^\circ C$.

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DC ELECTRICAL CHARACTERISTICS (2.5V \pm 0.2V RANGE)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT	
			Temp = -40°C to +85°C				
			MIN	TYP ¹	MAX		
V_{IK}	Input clamp voltage	$V_{CC} = 2.3V$; $I_{IK} = -18mA$		-0.85	-1.2	V	
V_{OH}	High-level output voltage	$V_{CC} = 2.3$ to $3.6V$; $I_{OH} = -100\mu A$	$V_{CC} - 0.2$	V_{CC}		V	
		$V_{CC} = 2.3V$; $I_{OH} = -8mA$	1.8	2.1			
V_{OL}	Low-level output voltage	$V_{CC} = 2.3V$; $I_{OL} = 100\mu A$		0.07	0.2	V	
		$V_{CC} = 2.3V$; $I_{OL} = 8mA$		0.3	0.4		
		$V_{CC} = 2.3V$; $I_{OL} = 24mA$		0.3	0.5		
I_I	Input leakage current	$V_{CC} = 2.7V$; $V_I = V_{CC}$ or GND	Control pins	0.1	± 1	μA	
		$V_{CC} = 0$ or $2.7V$; $V_I = 5.5V$		0.1	10		
		$V_{CC} = 2.7V$; $V_I = V_{CC}$	Data pins ⁴	0.1	1		
		$V_{CC} = 2.7V$; $V_I = 0$		0.1	-5		
I_{OFF}	Off current	$V_{CC} = 0V$; V_I or $V_O = 0$ to $4.5V$		0.1	± 100	μA	
I_{HOLD}	Bus Hold current Data inputs ⁶	$V_{CC} = 2.3V$; $V_I = 0.7V$		90		μA	
		$V_{CC} = 2.3V$; $V_I = 1.7V$		-10			
I_{EX}	Current into an output in the High state when $V_O > V_{CC}$	$V_O = 5.5V$; $V_{CC} = 2.3V$		10	125	μA	
$I_{PU/PD}$	Power up/down 3-State output current ³	$V_{CC} \leq 1.2V$; $V_O = 0.5V$ to V_{CC} ; $V_I = GND$ or V_{CC} OE/\overline{OE} = Don't care		1	± 100	μA	
I_{OZH}	3-State output High current	$V_{CC} = 2.7V$; $V_O = 2.3V$; $V_I = V_{IL}$ or V_{IH}		0.5	5	μA	
I_{OZL}	3-State output Low current	$V_{CC} = 2.7V$; $V_O = 0.5V$; $V_I = V_{IL}$ or V_{IH}		0.5	-5	μA	
I_{CCH}	Quiescent supply current	$V_{CC} = 2.7V$; Outputs High, $V_I = GND$ or V_{CC} , $I_O = 0$		0.04	0.1	mA	
I_{CCL}		$V_{CC} = 2.7V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_O = 0$		2.3	4.5		
I_{CCZ}		$V_{CC} = 2.7V$; Outputs Disabled; $V_I = GND$ or V_{CC} , $I_O = 0^5$		0.04	0.1		
ΔI_{CC}	Additional supply current per input pin ²	$V_{CC} = 2.3V$ to $2.7V$; One input at $V_{CC} - 0.6V$, Other inputs at V_{CC} or GND		0.04	0.4	mA	

NOTES:

- All typical values are at $V_{CC} = 2.5V$ and $T_{amb} = 25^\circ C$.
- This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND
- This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From $V_{CC} = 1.2V$ to $V_{CC} = 2.5V \pm 0.2V$ a transition time of 100 μ sec is permitted. This parameter is valid for $T_{amb} = 25^\circ C$ only.
- Unused pins at V_{CC} or GND.
- I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.
- Not guaranteed.

AC CHARACTERISTICS (2.5V \pm 0.2V RANGE) $GND = 0V$; $t_R = t_F = 2.5ns$; $C_L = 50pF$; $R_L = 500\Omega$; $T_{amb} = -40^\circ C$ to $+85^\circ C$.

SYMBOL	PARAMETER	WAVEFORM	LIMITS			UNIT	
			$V_{CC} = 2.5V \pm 0.2V$				
			MIN	TYP ¹	MAX		
t_{PLH} t_{PHL}	Propagation delay nAx to nBx or nBx to nAx	1	0.5 0.5	1.8 1.7	2.9 2.8	ns	
t_{PZH} t_{PZL}	Output enable time to High and Low level	2	1.5 1.5	4.4 3.3	6.5 5.2	ns	
t_{PHZ} t_{PLZ}	Output disable time from High and Low Level	2	1.5 1.0	3.2 2.5	4.9 3.9	ns	

NOTE:

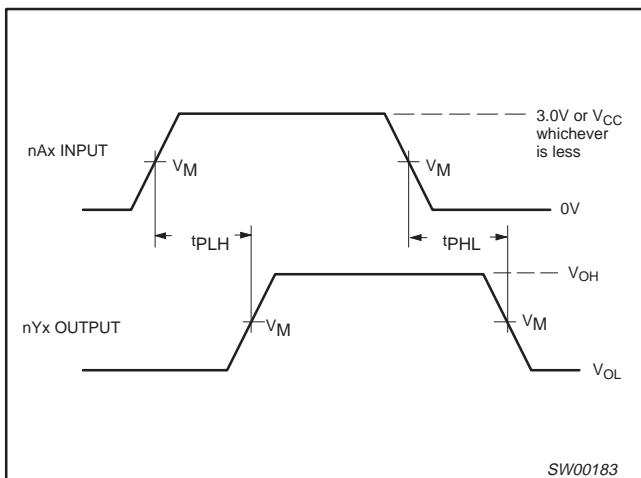
- All typical values are at $V_{CC} = 2.5V$ and $T_{amb} = 25^\circ C$.

2.5V/3.3V 16-bit buffer/driver (3-State)

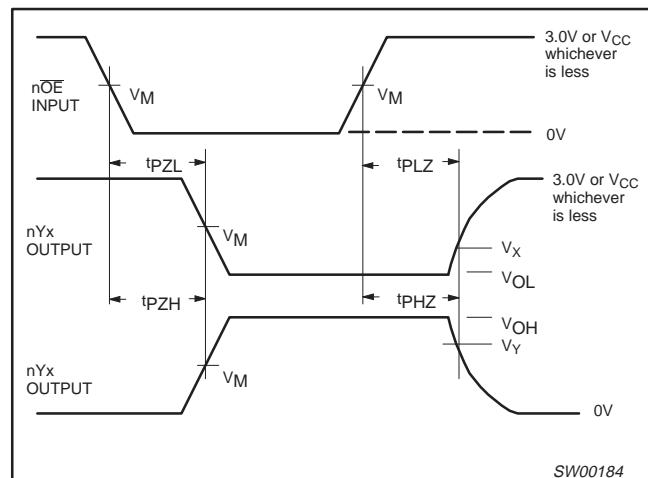
74ALVT16541

AC WAVEFORMS

$V_M = 1.5V$ at $V_{CC} \geq 3.0V$; $V_M = V_{CC}/2$ at $V_{CC} \leq 2.7V$
 $V_X = V_{OL} + 0.3V$ at $V_{CC} \geq 3.0V$; $V_X = V_{OL} + 0.15V$ at $V_{CC} \leq 2.7V$
 $V_Y = V_{OH} - 0.3V$ at $V_{CC} \geq 3.0V$; $V_Y = V_{OH} - 0.15V$ at $V_{CC} \leq 2.7V$

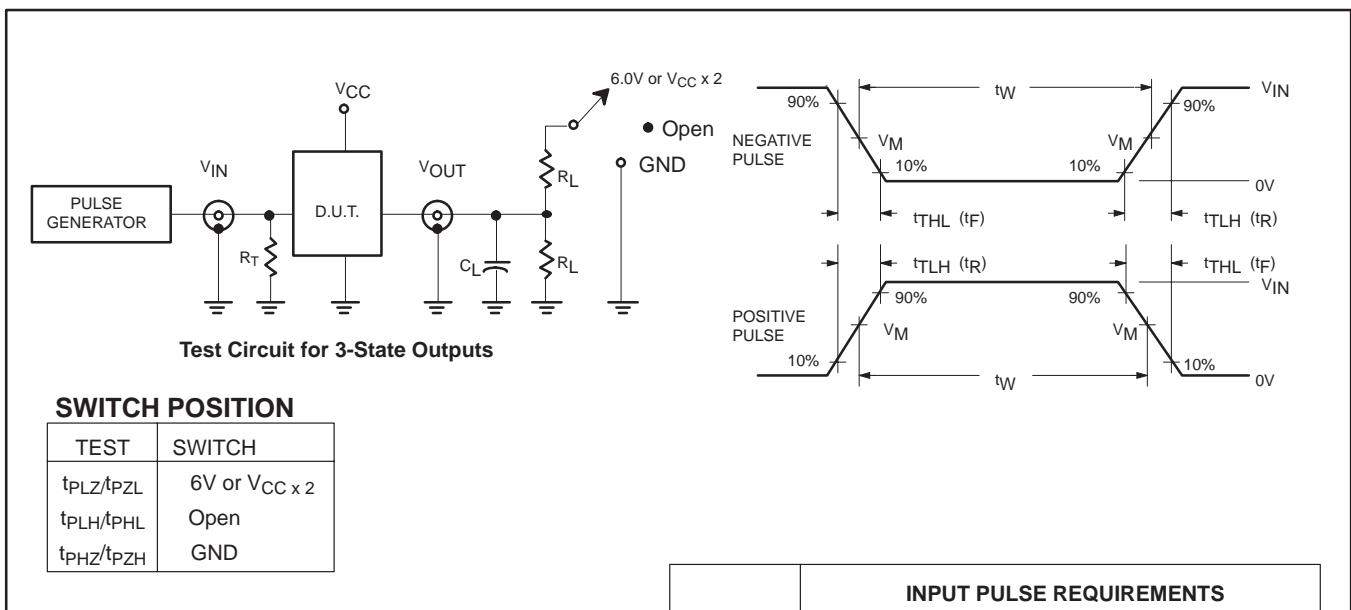


Waveform 1. Input to Output Propagation Delays



Waveform 2. 3-State Output Enable and Disable Times

TEST CIRCUIT AND WAVEFORMS



SWITCH POSITION

TEST	SWITCH
t_{PLZ}/t_{PZL}	6V or $V_{CC} \times 2$
t_{PLH}/t_{PHL}	Open
t_{PHZ}/t_{PZH}	GND

DEFINITIONS

- R_T = Load resistor; see AC CHARACTERISTICS for value.
 C_L = Load capacitance includes jig and probe capacitance: See AC CHARACTERISTICS for value.
 R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.

FAMILY	INPUT PULSE REQUIREMENTS				
	Amplitude	Rep. Rate	t_W	t_R	t_F
74ALVT16	3.0V or V_{CC} whichever is less	$\leq 10MHz$	500ns	$\leq 2.5ns$	$\leq 2.5ns$

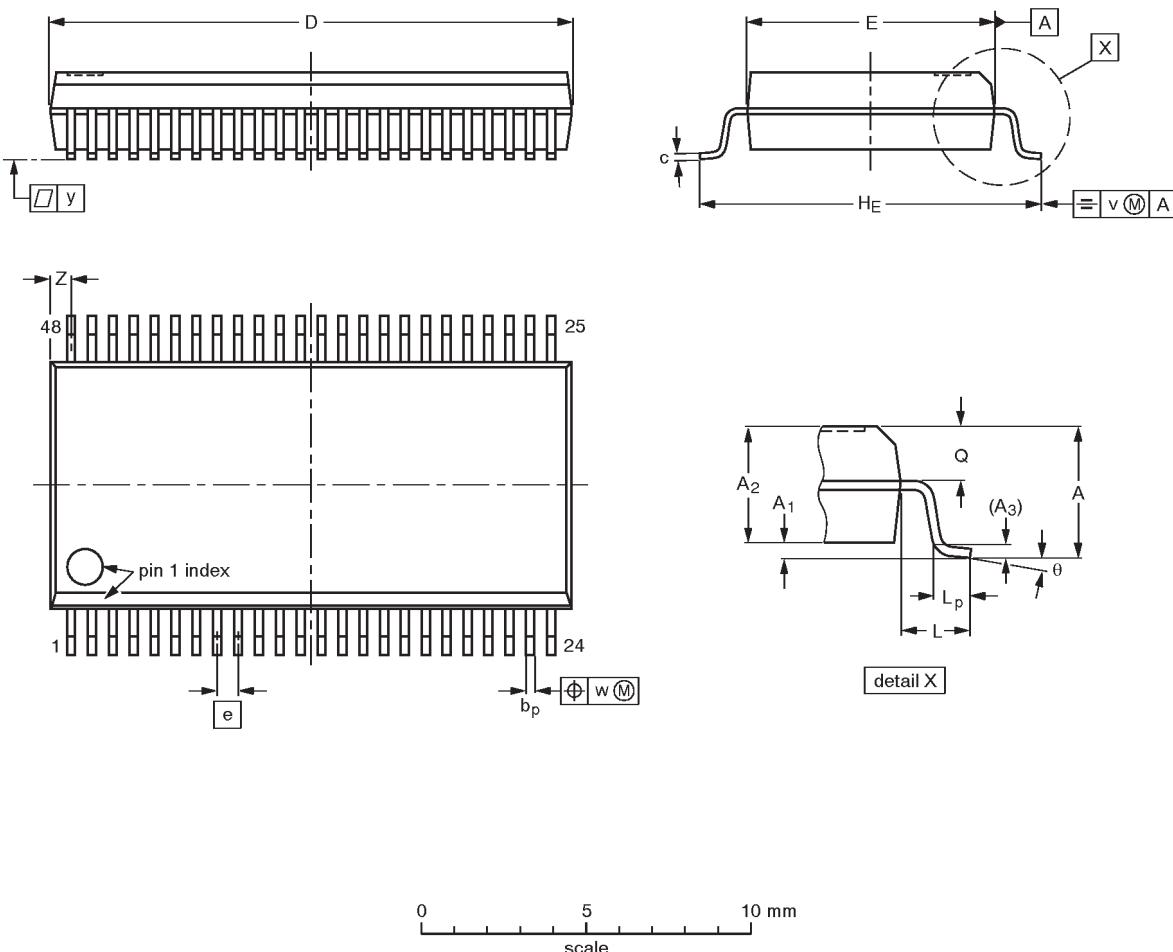
SW00025

2.5V/3.3V 16-bit buffer/driver (3-State)

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SSOP48: plastic shrink small outline package; 48 leads; body width 7.5 mm

SOT370-1



DIMENSIONS (mm are the original dimensions)

UNIT	A _{max.}	A ₁	A ₂	A ₃	b _p	c	D ⁽¹⁾	E ⁽¹⁾	e	H _E	L	L _p	Q	v	w	y	Z ⁽¹⁾	θ
mm	2.8 0.2	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	16.00 15.75	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

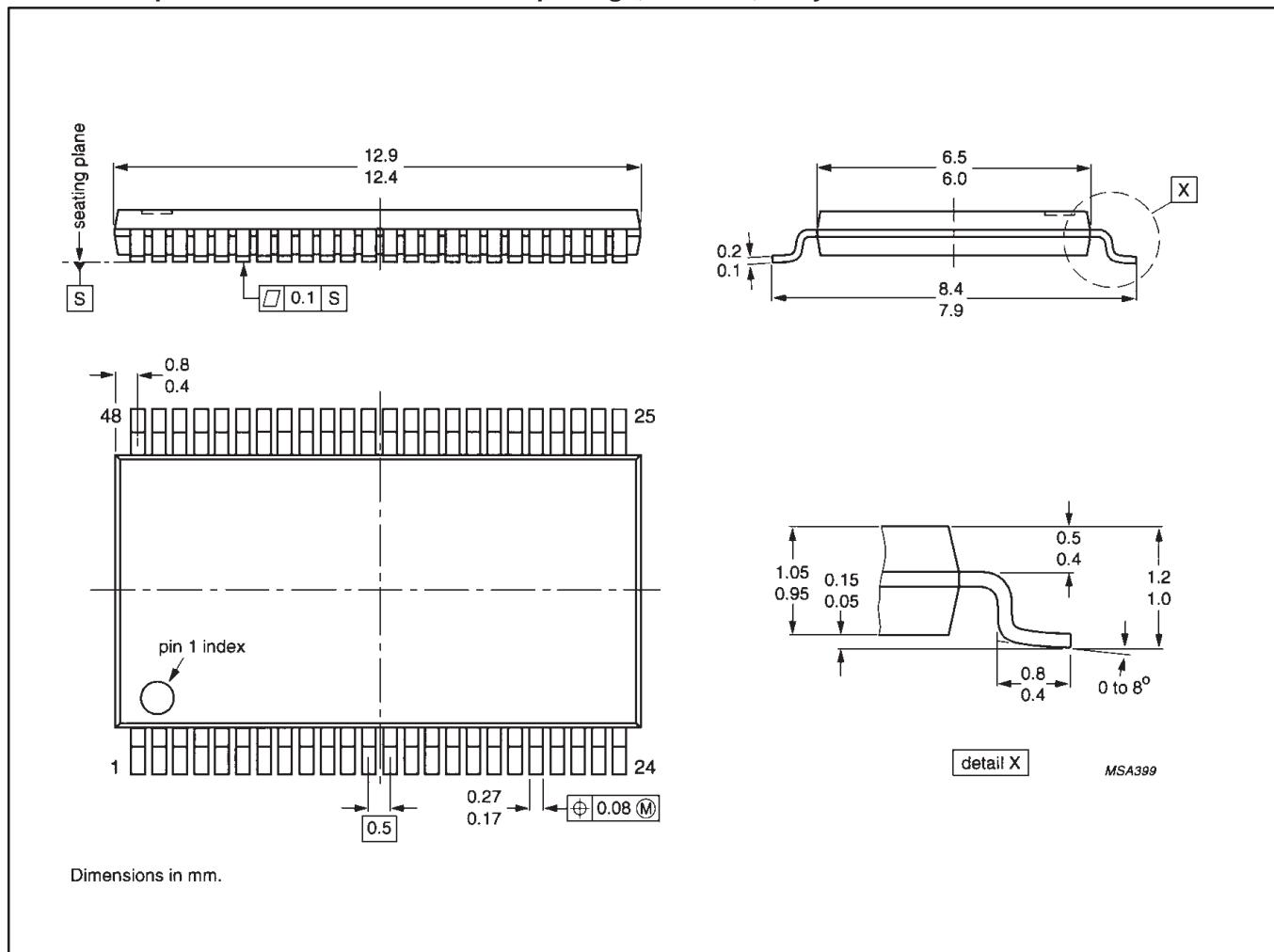
OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT370-1		MO-118AA				93-11-02 95-02-04

2.5V/3.3V 16-bit buffer/driver (3-State)

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TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1mm

SOT362-1



2.5V/3.3V 16-bit buffer/driver (3-State)

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued datasheet before initiating or completing a design.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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